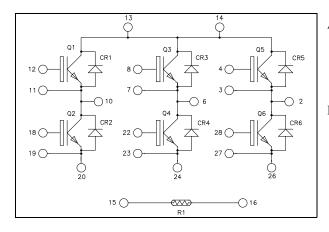
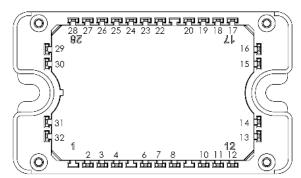


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Triple phase leg High speed IGBT 5 Power Module





Pins 20, 24 & 26 must be shorted together to perform a 3 phase bridge.

# $V_{CES} = 650V$ ; $I_C = 50A$ @ $Tc = 25^{\circ}C$

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### Features

- High speed IGBT 5
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Low leakage current
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

# All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

# Absolute maximum ratings (Per IGBT)

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Voltage		650	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	50	
I <sub>C</sub>	Continuous Collector Current $T_{C} = 80^{\circ}C$		30	Α
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V <sub>GE</sub>	Gate – Emitter Voltage		$\pm 20$	V
P <sub>D</sub>	Power Dissipation		125	W

These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed.

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# Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 650V$				50	μΑ
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.65	2.2	V
V <sub>CE(sat)</sub>		$I_C = 50A$	$T_{j} = 150^{\circ}C$		1.9		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 0.5 \text{mA}$		3.3	4.0	4.7	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				120	nA

# Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$			3000		
C <sub>oes</sub>	Output Capacitance				50		pF
Cres	Reverse Transfer Capacitance	f = 1 MHz		11			
Q <sub>G</sub>	Gate charge	$V_{GE} = 15V, I_C = 50A$ $V_{CE} = 520V$			120		nC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)			21		
Tr	Rise Time	$V_{GE} = 15V$			15		I.
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 25A$ $R_{G} = 12\Omega$			180		ns
$T_{\rm f}$	Fall Time				18		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = 15V$ $V_{Bus} = 400V$ $I_C = 25A$ $R_G = 12\Omega$			20		
Tr	Rise Time				15		
T <sub>d(off)</sub>	Turn-off Delay Time				205		ns
$T_{\rm f}$	Fall Time				26		
Eon	Turn on Energy	$V_{GE} = 15V$ $V_{Bus} = 400V$	$T_j = 150^{\circ}C$		0.75		mJ
E <sub>off</sub>	Turn off Energy	$I_{\rm C} = 25 A$ $R_{\rm G} = 12 \Omega$	$T_j = 150^{\circ}C$		0.3		1113
$R_{thJC}$	Junction to Case Thermal Resistance					1.2	°C/W

# Diode ratings and characteristics (per diode)

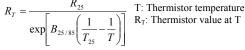
Symbol	Characteristic	ic Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					650	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =650V				50	μA
I <sub>F</sub>	DC Forward Current		$Tc = 25^{\circ}C$		50		Α
V	Diode Forward Voltage	$I_F = 50A$	$T_i = 25^{\circ}C$		1.6	2.2	v
$V_{\rm F}$		$I_{\rm F} = 50 {\rm A} \\ V_{\rm GE} = 0 {\rm V} $	$T_{i} = 150^{\circ}C$		1.65		v
t <sub>rr</sub>	Reverse Recovery Time	I - 25 A	$T_j = 25^{\circ}C$		46		ns
۰rr	Reverse Recovery Time		$T_{j} = 150^{\circ}C$		62		115
0	$Q_{rr}$ Reverse Recovery Charge $V_R = 400 V$ di/dt =1500A/µs	$T_j = 25^{\circ}C$		0.5		чС	
Qπ			$T_{j} = 150^{\circ}C$		1		μC
R <sub>thJC</sub>	Junction to Case Thermal Resistance					1.4	°C/W



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## Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

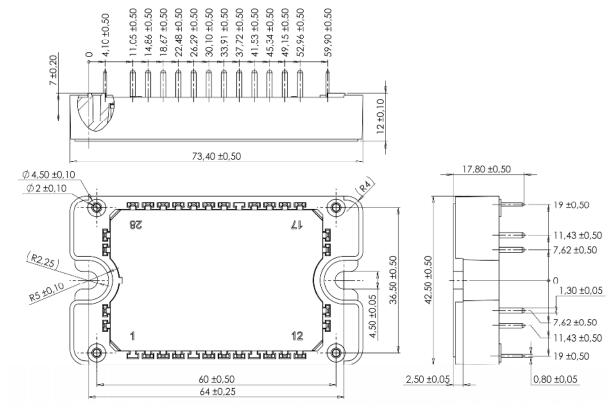
Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%
	R <sub>ec</sub> To The second states to second					



# **Package characteristics**

Symbol	Characteristic			Min	Max	Unit
VISOL	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V
T <sub>J</sub>	Operating junction temperature range			-40	175	
T <sub>JOP</sub>	Recommended junction temperature under switching conditions			-40	T <sub>J</sub> max -25	°C
T <sub>STG</sub>	Storage Temperature Range			-40	125	C
T <sub>C</sub>	Operating Case Temperature			-40	125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

# Package outline (dimensions in mm)

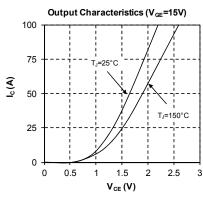


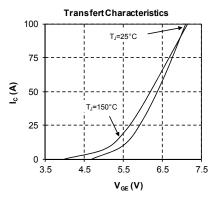
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

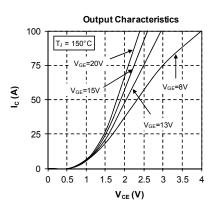


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# **Typical Performance Curve**

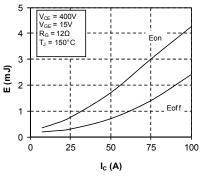






APTGTQ50TA65T3G

Energy losses vs Collector Current



1.25 1 Eor **1** 0.75 **E** 0.5 0.5 Eoff V<sub>CE</sub> = 400V V<sub>GE</sub> =15V I<sub>C</sub> = 25A T<sub>J</sub> = 150°C

30

Gate Resistance (ohms)

40

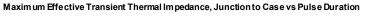
50

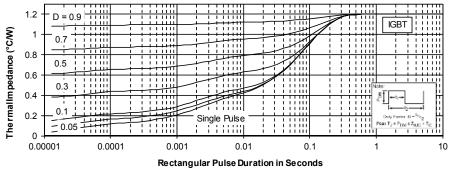
20

0.25

0 10

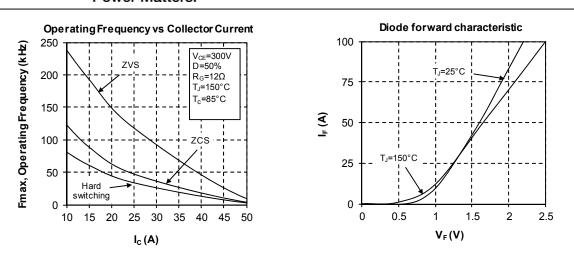
Switching EnergyLosses vs Gate Resistance



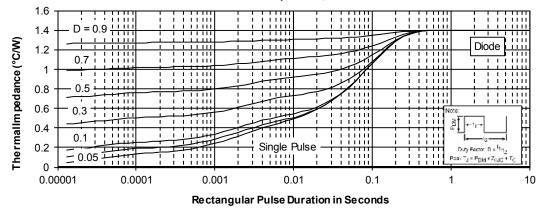


www.microsemi.com





Maxim um Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



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